

## Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)}$ max	$I_D$ max $T_A = 25^\circ C$
30V	21mΩ @ $V_{GS} = 10V$	7.3A
	35mΩ @ $V_{GS} = 4.5V$	5.5A

## Description and Applications

This MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

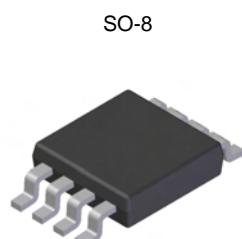
- Backlighting
- Power Management Functions
- DC-DC Converters

## Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- **ESD Protected Gate**
- “Green” component and RoHS compliant (Notes 1 & 2)
- Qualified to AEC-Q101 standards for High Reliability

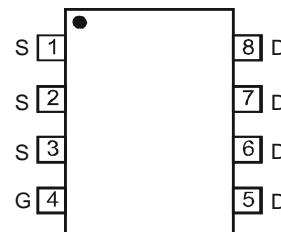
## Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, “Green” Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish — Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.008 grams (approximate)

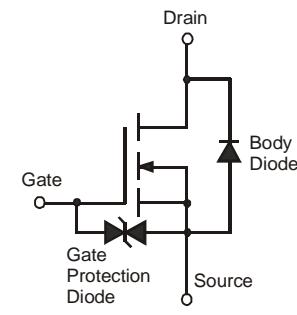


SO-8

Top View



Top View  
Pin Configuration



Equivalent Circuit Per Element

## Ordering Information (Note 3)

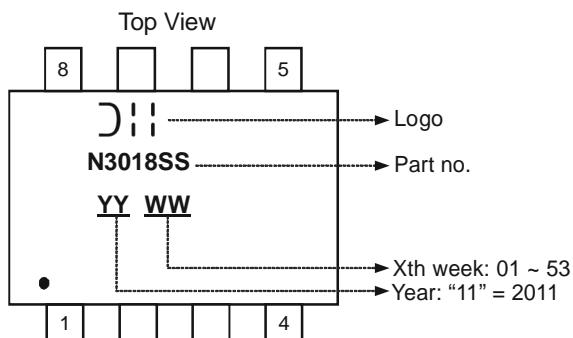
Part Number	Case	Packaging
DMN3018SSS-13	SO-8	2500/Tape & Reel

Notes: 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. No purposely added lead. Halogen and Antimony free.

2. Diodes Inc.’s “Green” policy can be found on our website at <http://www.diodes.com>.

3. For packaging details, go to our website at <http://www.diodes.com>.

## Marking Information



**Maximum Ratings** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			$V_{DSS}$	30	V
Gate-Source Voltage			$V_{GSS}$	$\pm 25$	V
Continuous Drain Current (Note 5) $V_{GS} = 10\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	7.3 5.7	A
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	9.7 7.8	A
Continuous Drain Current (Note 5) $V_{GS} = 4.5\text{V}$	Steady State	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	5.5 4.3	A
	$t < 10\text{s}$	$T_A = 25^\circ\text{C}$ $T_A = 70^\circ\text{C}$	$I_D$	7.6 5.8	A
Pulsed Drain Current (10 $\mu\text{s}$ pulse, duty cycle = 1%)			$I_{DM}$	60	A
Maximum Body Diode continuous Current			$I_S$	2.5	A

**Thermal Characteristics** @ $T_A = 25^\circ\text{C}$  unless otherwise specified

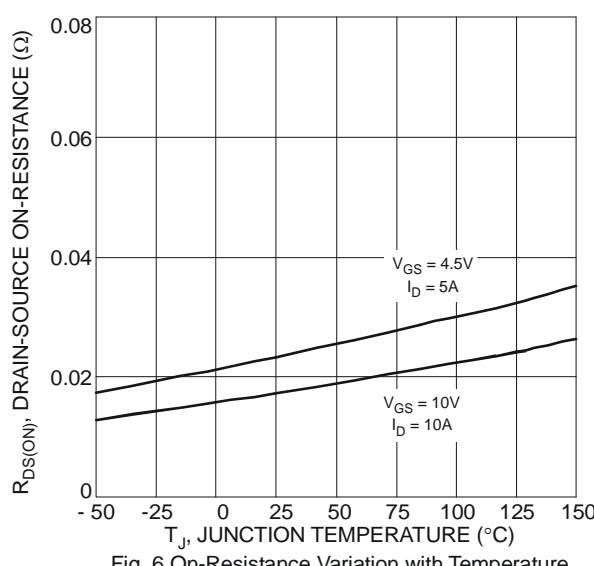
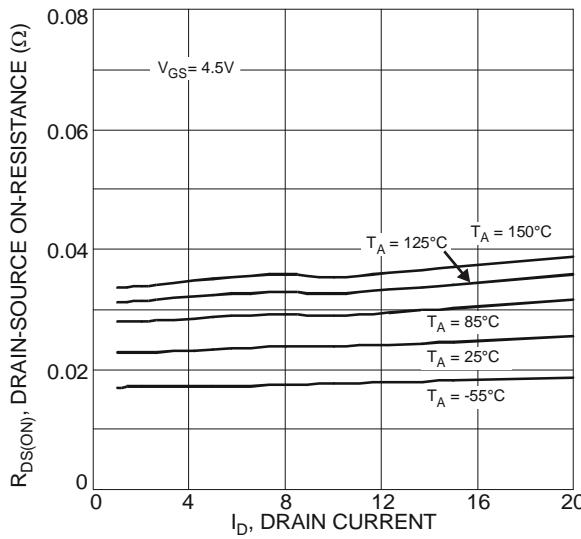
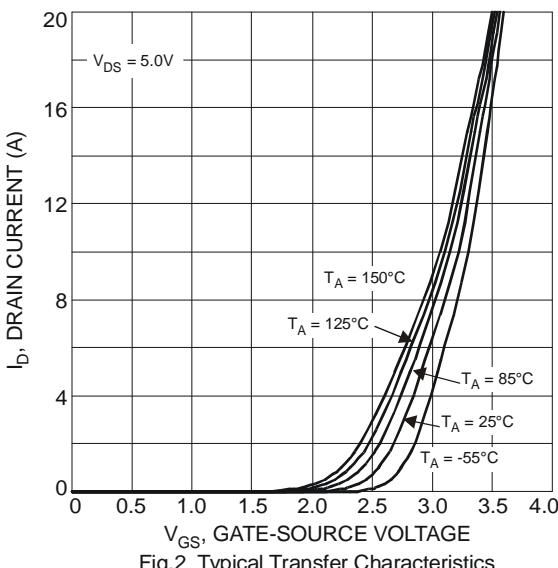
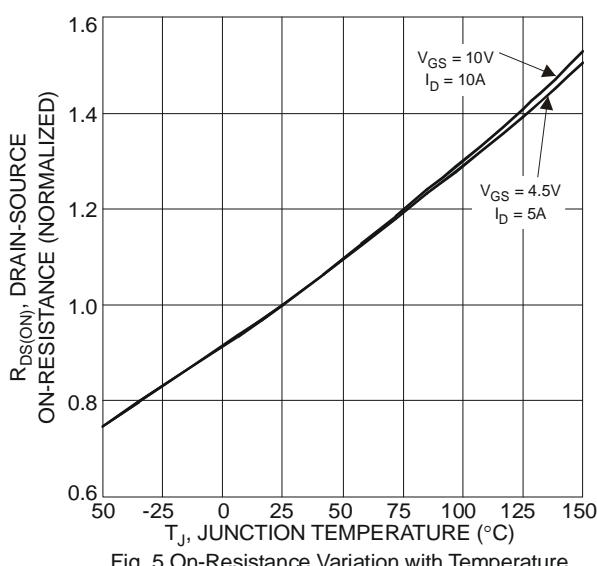
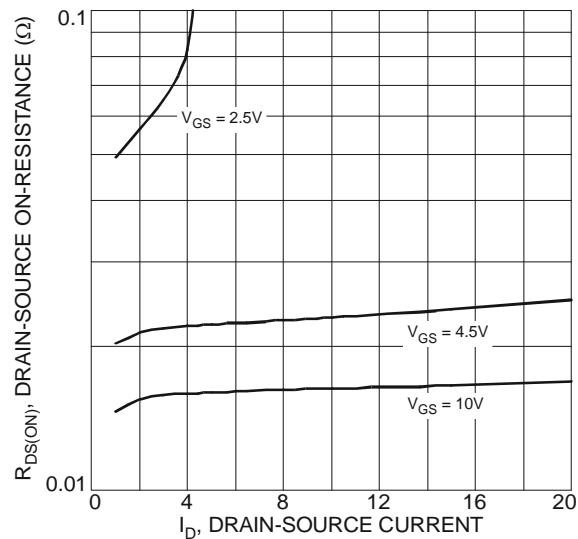
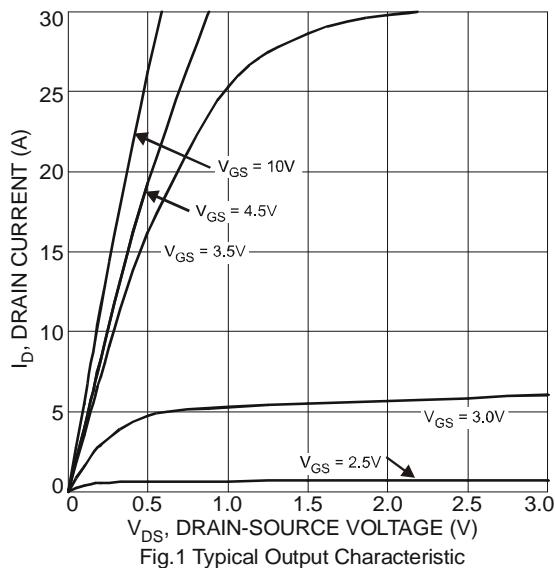
Characteristic		Symbol	Value	Units
Total Power Dissipation (Note 4)	$T_A = 25^\circ\text{C}$	$P_D$	1.4	W
	$T_A = 70^\circ\text{C}$		0.9	
Thermal Resistance, Junction to Ambient (Note 4)	Steady state	$R_{\theta JA}$	90	$^\circ\text{C/W}$
	$t < 10\text{s}$		50	
Total Power Dissipation (Note 5)	$T_A = 25^\circ\text{C}$	$P_D$	1.7	W
	$T_A = 70^\circ\text{C}$		1.1	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	$R_{\theta JA}$	75	$^\circ\text{C/W}$
	$t < 10\text{s}$		42	
Thermal Resistance, Junction to Case (Note 5)		$R_{\theta JC}$	7.6	$^\circ\text{C/W}$
Operating and Storage Temperature Range		$T_J, T_{STG}$	-55 to +150	$^\circ\text{C}$

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
<b>OFF CHARACTERISTICS (Note 6)</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	30	-	-	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	$I_{GSS}$	-	-	$\pm 10$	$\mu\text{A}$	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$
<b>ON CHARACTERISTICS (Note 6)</b>						
Gate Threshold Voltage	$V_{GS(\text{th})}$	1	1.7	2.1	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	-	15	21	$\text{m}\Omega$	$V_{GS} = 10\text{V}, I_D = 10\text{A}$
		-	20	35		$V_{GS} = 4.5\text{V}, I_D = 8.5\text{A}$
Forward Transfer Admittance	$ Y_{fs} $	-	8.3	-	S	$V_{DS} = 5\text{V}, I_D = 6.9\text{A}$
Diode Forward Voltage	$V_{SD}$	0.5	-	1.2	V	$V_{GS} = 0\text{V}, I_S = 1\text{A}$
<b>DYNAMIC CHARACTERISTICS (Note 7)</b>						
Input Capacitance	$C_{iss}$	-	697	-	pF	$V_{DS} = 15\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	$C_{oss}$	-	97	-	pF	
Reverse Transfer Capacitance	$C_{rss}$	-	67	-	pF	
Gate resistance	$R_g$	-	1.47	-	$\Omega$	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Total Gate Charge ( $V_{GS} = 4.5\text{V}$ )	$Q_g$	-	6.0	-	nC	$V_{GS} = 10\text{V}, V_{DS} = 15\text{V}, I_D = 9\text{A}$
Total Gate Charge ( $V_{GS} = 10\text{V}$ )	$Q_g$	-	13.2	-	nC	
Gate-Source Charge	$Q_{gs}$	-	2.2	-	nC	
Gate-Drain Charge	$Q_{qd}$	-	1.8	-	nC	
Turn-On Delay Time	$t_{D(\text{on})}$	-	4.3	-	ns	$V_{DD} = 15\text{V}, V_{GS} = 10\text{V}, R_L = 15\Omega, I_D = 1\text{A}, R_G = 6\Omega$
Turn-On Rise Time	$t_r$	-	4.4	-	ns	
Turn-Off Delay Time	$t_{D(\text{off})}$	-	20.1	-	ns	
Turn-Off Fall Time	$t_f$	-	4.1	-	ns	
Reverse Recovery Time	$T_{rr}$	-	7.3	-	ns	$I_F = 9\text{A}, di/dt = 500\text{A}/\mu\text{s}$
Reverse Recovery Charge	$Q_{rr}$	-	7.9	-	nC	

Notes:

4. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
6. Short duration pulse test used to minimize self-heating effect.
7. Guaranteed by design. Not subject to product testing.



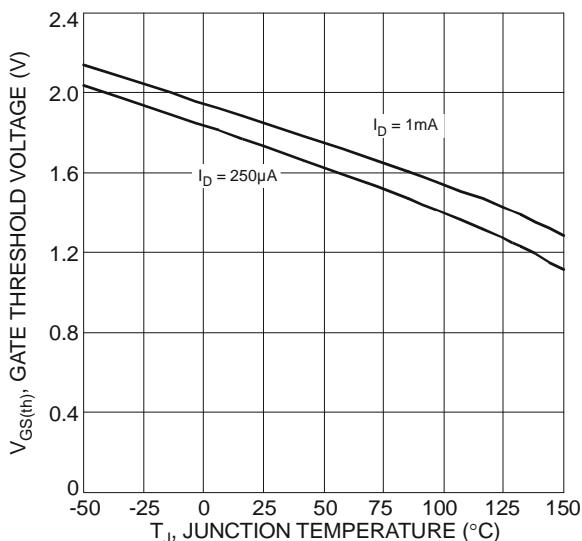


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

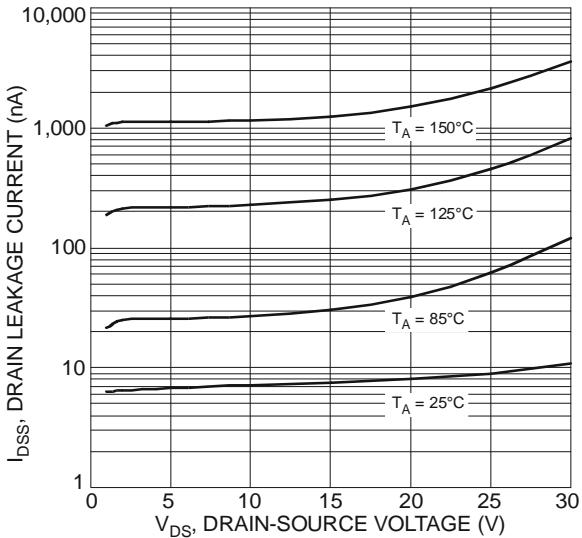


Fig. 9 Typical Drain-Source Leakage Current vs. Voltage

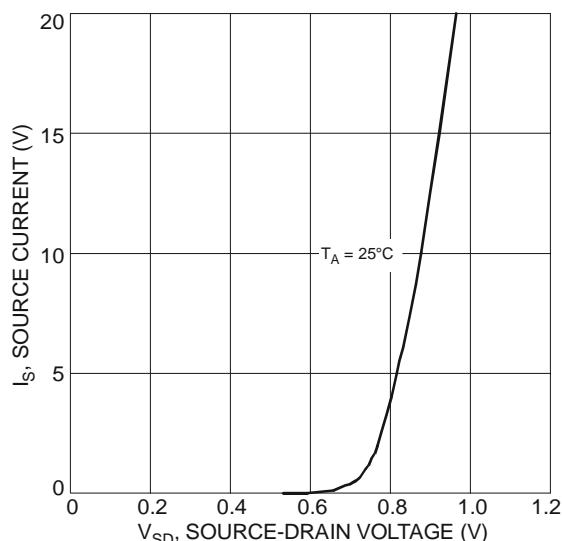


Fig. 8 Diode Forward Voltage vs. Current

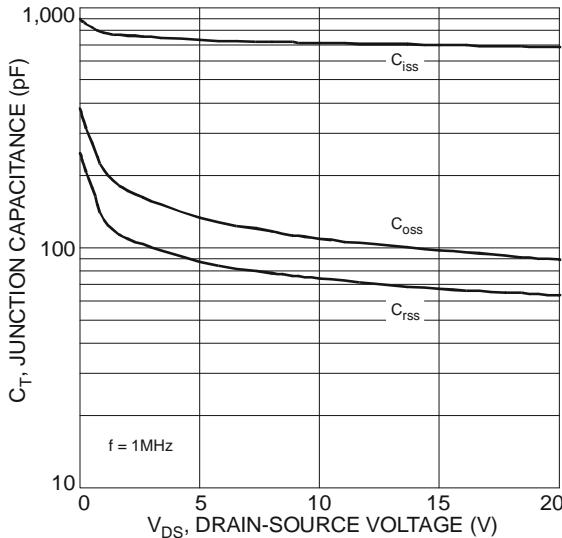


Fig. 10 Typical Junction Capacitance

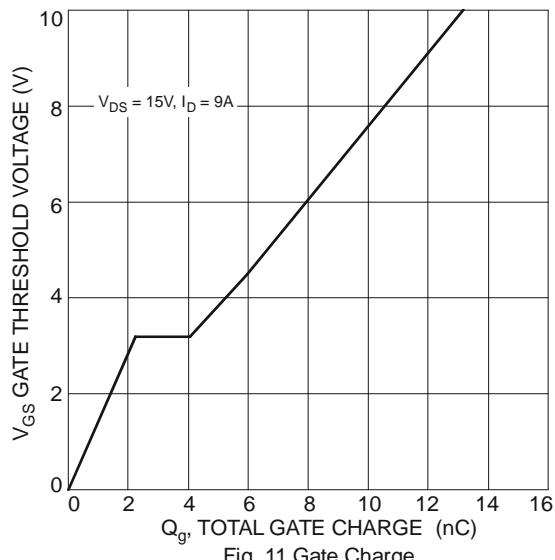


Fig. 11 Gate Charge

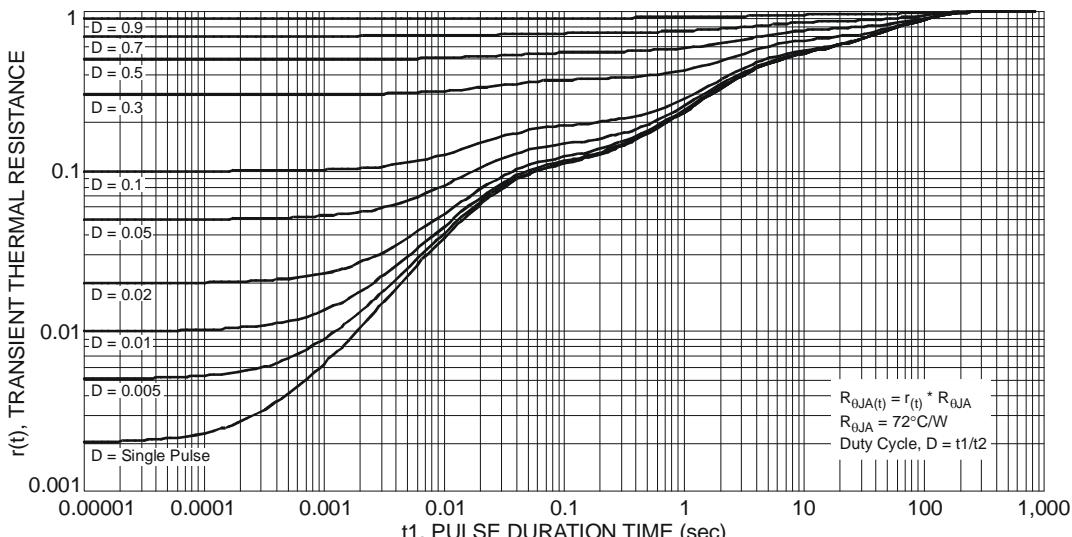
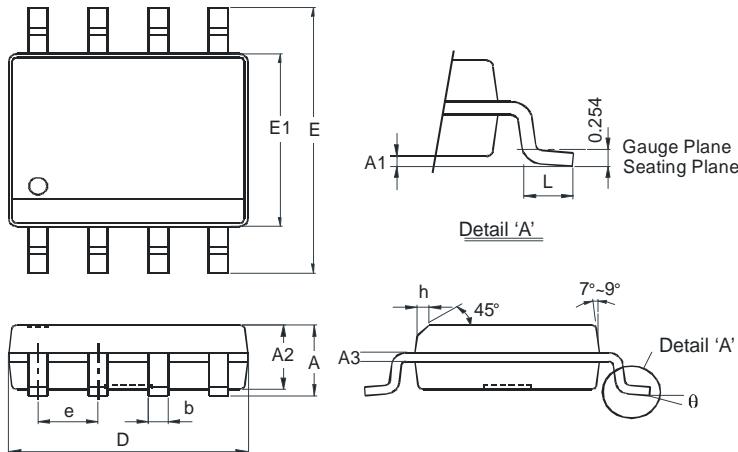


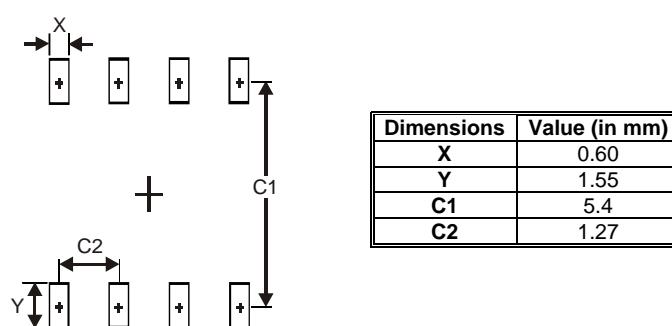
Fig. 12 Transient Thermal Resistance

## Package Outline Dimensions



SO-8		
Dim	Min	Max
<b>A</b>	-	1.75
<b>A1</b>	0.10	0.20
<b>A2</b>	1.30	1.50
<b>A3</b>	0.15	0.25
<b>b</b>	0.3	0.5
<b>D</b>	4.85	4.95
<b>E</b>	5.90	6.10
<b>E1</b>	3.85	3.95
<b>e</b>	1.27 Typ	
<b>h</b>	-	0.35
<b>L</b>	0.62	0.82
<b>θ</b>	0°	8°
All Dimensions in mm		

## Suggested Pad Layout



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